Search Notes

Application	n/Control No.	Applicant(s)/Patent und Reexamination	ier
09/683,69	6	REBELLO ET AL.	
Examiner		Art Unit	
Ayal I. Sha	aron	2123	

SEARCHED					
Class	Subclass	Date	Examiner		
703	6,7	1/30/2006	ayal		
700	97, 182	1/30/2006	ayal		

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST, IEEE See attached search notes	1/30/2006	agel		
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